

**Notice of References Cited**

Application/Control No.

10/596,692

Applicant(s)/Patent Under  
Reexamination  
HIRABAYASHI ET AL.

Examiner

Bao-Thuy L. Nguyen

Art Unit

1641

Page 1 of 1

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	D	US-			
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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